PCN Number:		20150922000						F	PCN Da	ate:	09/24/2015		
Title: TPS6302			250RNCR/T Conversion to Green										
Cus	stomer C	onta	ct:	PCN A	<u>lanager</u>		Dept:	Quality Services					
			12/24	/20	15	Estimated Sample Date provided at sample request				•			
Cha	ange Typ									Mafar	. Dum	n Cita	
	Assembly Site				Design L Data Sheet			\mathbb{H}	Wafer Bump Site Wafer Bump Material				
\boxtimes	•				H					Wafer Bump Process			
	Mechanical Specification				H	Test Site				Wafer Fab Site			
Ħ	Packing/Shipping/Labeling			ng	Ī	Test Process						Materials	
	<u> </u>		, <u>J</u> ,		<u> </u>						Wafer Fab Process		
	PCN Details												
Des	scription	of C	hang	e:									
Texas Instruments is pleased to announce the conversion to green status for the TPS630250RNCR/T device. A change from lead based (SnPb) solder paste to lead free (Pb free) solder paste for the assembly process will be internal to the package and will not affect customer usage.													
						e P	illar Sol	der Paste	ECAT				
			Current			Le	ad (SnPl	b) base	e4				
			New			Sn (Pb free) base				G4			
Rea	ason for	Char	ige:										
Mig	ration to	Gree	n stat	us									
Ant	ticipated	imp	act o	n For	m, Fit,	Fu	nction,	Quality or R	eliabi	lity	(positi	ive /	negative):
Nor	ne												
Ant	ticipated												
				prod rele obta	Material Declarations or Product Content reports are driven from production data and will be available following the production release. Upon production release the revised reports can be obtained from the <u>TI ECO website</u> .								
Cha	anges to	proc	luct i	denti	ficatio	n re		from this P					
		Current				Device Symbolization							
NO.	TE, The	datas	New		undate	+ !O ! YM = YEAR MONTH DATE CODE ! 63025P ! S = ASSEMBLY SITE CODE ! TI YMS ! LLLL = ASSY LOT CODE ! LLLL ! ++ O - PIN 1 (MARKED)					vices		

TI Label, ECAT Information:

TEXAS
INSTRUMENTS
MADE IN: Malaysia
2DC: 20:

2DC: 20; MSL 2 /260C/1 YEAR SEAL DT

MSL 1 /235C/UNLIM 03/29/04

DPT: 1750 LBL: 5A (L)T0:1750

Before Change: e4
After Change: G4



(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483812

(P) (2P) REV: (V) 0033317 (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS

Product Affected:

TPS630250RNCR TPS630250RNCT

G4

TEXAS INSTRUMENTS TI Information Selective Disclosure

Qualification Report

TPS630250PRNC (LBC7/HotRod with Pb free Solder)

Approve Date 25-Aug-2015

Product Attributes

Die Attributes	Qual Device: TPS630250PRNC	QBS Process Reference: TPS65830YFF	QBS Package Reference: TPS22993RLWR	QBS Package Reference: TPS62085RLT	
Die Revision	A3	PG1.2	A	PG1.2/B1	
Wafer Fab Supplier	RFAB	RFAB	RFAB	MIH08	
Wafer Process	LBC7	LBC7	LBC7	LBC7	
Package Attributes	Qual Device: TPS630250PRNC	QBS Process Reference: TPS65830YFF	QBS Package Reference: TPS22993RLWR	QBS Package Reference: TPS62085RLT	
Assembly Site	TI-CLARK	TI-CLARK	TI-CLARK	TI-CLARK	
Package Family	QFN	WCSP	QFN	QFN	
Package Designator	RNC	YFF	RLW	RLT	
Package Size (mils)	98.4 X 98.4	118.11 X 118.11	118.11 X 118.11	78.74 × 78.74	
Body Thickness (mils)	35.4	24.61	29.53	39.37	
Pin Count	14	49	20	7	
Lead Frame Type	Cu	Cu	Cu	Cu	
Lead Finish	NiPdAu	-	NiPdAu	NiPdAu	
Lead Pitch(mils)	19.68	15.75	15.75	19.68	
Bump Composition	-	SnAgCu	-	-	
Flammability Rating	UL 94 V-0	UL 94 V-0	-	UL 94 V-0	

⁻ QBS: Qual By Similarity

⁻ Qual Device TPS630250PRNC is qualified at LEVEL1-260C

Qualification Results

Data Displayed as: Number of lots / Total sample size / Total failed

	Data Displayed as: Number of lots / Total sample size / Total failed					
Туре	Test Name / Condition	Duration	Qual Device: TPS630250PRNC	QBS Process Reference: TPS65830YFF	QBS Package Reference: TPS22993RLWR	QBS Package Reference: TPS62085RLT
AC	Autoclave 121C	96 Hours	-	-	3/231/0	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	Pass	Pass
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	3/231/0
HBM	ESD - HBM	4000 V	1/3/0	-	-	-
CDM	ESD - CDM	1500 V	1/3/0	-	-	3/9/0
HTOL	Life Test, 125C	1000 Hours	-	-	1/77/0	-
HTOL	Life Test, 150C	300 Hours	-	3/231/0	-	-
HTSL	High Temp. Storage Bake, 150C	1000 Hours	3/231/0	-	-	3/231/0
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	-	3/231/0	-
LU	Latch-up	(per JESD78)	3/18/0	3/18/0	-	-
PD	Physical Dimensions		3/15/0	-	3/15/0	3/15/0
SD	Solderability	8 Hours Steam Age	-	-	-	3/66/0
TC	Temperature Cycle, - 55/125C	700 Cycles	3/231/0	3/229/0	3/231/0	3/231/0
TC	Temperature Cycle, - 65/150C	500 Cycles	-	-	-	-
UHAST	Unbiased HAST, 130C/85%RH	96 Hours	-	3/228/0	-	3/231/0

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com

¹³⁰C/859kH

- The Conditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shook, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47:-55C/125C/100 Cycles and -55C/150C/500 Cycles